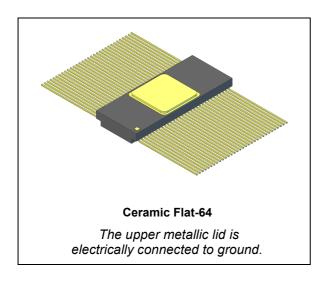


RHFLVDS2281

Rad-hard, dual 4x4 crosspoint switch LVDS

Datasheet - production data



Features

- LVDS input/output
- Multiple configuration: Mux, repeater and splitter
- ANSI TIA/EIA-644 compliant
- 400 Mbps LVDS (200 MHz)
- 200 MHz clock channel
- Cold spare on all pins
- Fail-safe function
- 3.3 V operating power supply
- 4.8 V absolute rating
- · Hermetic package
- Power consumption: 220 mW at 3.3 V
- Large input common mode: -4 V to +5 V
- Guaranteed up to 300 krad TID
- SEL immune up to 135 MeV.cm²/mg
- SET/SEU immune up to 22 MeV.cm²/mg
- SMD pin: 5962F14234
- Mass: 1.94 g

Description

The RHFLVDS2281 is an 8-channel, 4x4 crosspoint switch base, on low voltage differential signaling (LVDS) for low-power and high-speed communications. The two 4x4 multiplexers allow connection from any of the four inputs to any of the four outputs.

Packaged and qualified for use in aerospace environments in a low-power, fast-transmission standard, the RHFLVDS2281 operates at 3.3 V power supply (3.6 V max. operating and 4.8 V AMR) and a common mode of -4 V to +5 V. The LVDS outputs operate over a controlled impedance of 100-ohm transmission media that may be printed circuit board traces, back planes, or cables.

The circuit features an internal fail-safe function to ensure a known state in case of an input short circuit or a floating input.

All pins have cold spare buffers to ensure they are in high impedance when V_{CC} is tied to GND. The RHFLVDS2281 can operate over a wide temperature range of -55 °C to +125 °C and it is housed in a hermetic Ceramic Flat-64 package.

Contents RHFLVDS2281

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1 Functional description

Table 1. Mux truth table

SL1	SL2	SL3	SL4	OUT1	OUT2	OUT3	OUT4	Mode	
0	0	0	0	IN1	IN1	IN3	IN3	Splitter	
0	0	0	1	IN1	IN1	IN3	IN4	Splitter/repeater	
0	0	1	0	IN1	IN1	IN1	IN1	Splitter	
0	0	1	1	IN1	IN1	IN4	IN4	Splitter	
0	1	0	0	IN1	IN2	IN3	IN3	Splitter/repeater	
0	1	0	1	IN1	IN2	IN3	IN4	Repeater	
0	1	1	0	IN1	IN2	IN4	IN3	Repeater/switch	
0	1	1	1	IN1	IN2	IN4	IN4	Splitter/repeater	
1	0	0	0	IN2	IN2	IN2	IN2	Splitter	
1	0	0	1	IN2	IN1	IN3	IN4	Switch/repeater	
1	0	1	0	IN2	IN1	IN4	IN3	Switch	
1	0	1	1	IN3	IN3	IN3	IN3	Splittor	
1	1	0	0	IN2	IN2	IN3	IN3	Splitter	
1	1	0	1	IN2	IN2	IN3	IN4	Splitter/repeater	
1	1	1	0	IN4	IN4	IN4	IN4	Splitter	
1	1	1	1	IN2	IN2	IN4	IN4	Splitter	

Note: 1 A floating SL pin is equivalent to a low logic level

2 Channels 5, 6, 7, and 8 behave like channels 1, 2, 3 and 4 respectively (see also Figure 2)

Table 2. Enable (EN) truth table

EN	Inputs	Outputs		
EN	(IN+) - (IN-)	OUT+	OUT-	
L	X	Z	Z	
	Vid ≥ 0.1 V	Н	L	
U or floating	Vid ≤ -0.1 V	L	Н	
H or floating (internal pull-up)	-0.1V < Vid < +0.1 V	Unknown		
	Full fail-safe open/short or terminated	Н	L	

Note: Vid = (VIN+)-(VIN-), L = low level, H = high level, X = don't care, Z = high impedance



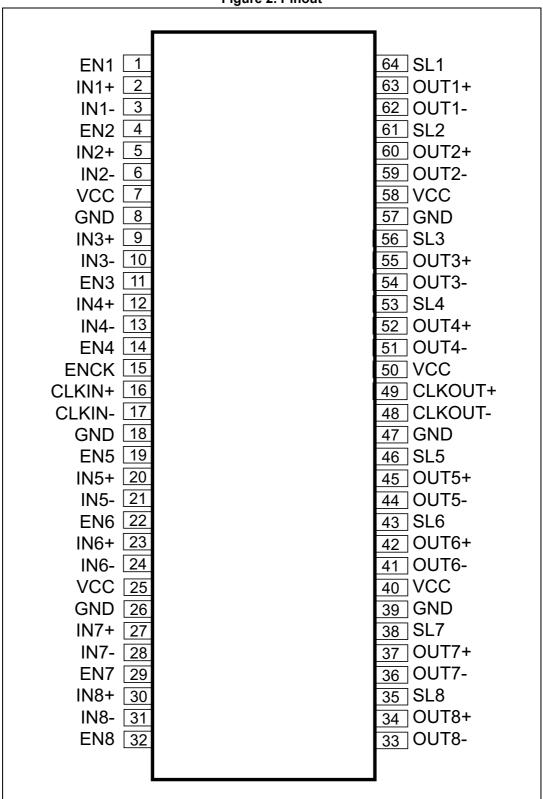
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2 Internal schematic and pin configuration

SL1 EN1 OUT1+ IN1+ IN1-OUT1-SL2 · EN2 IN2+ OUT2+ IN2-MUX OUT2-4x4 SL3 · EN3 IN3+ OUT3+ IN3-OUT3-SL4 EN4 IN4+ OUT4+ IN4-OUT4-ENK CLKIN+ CLKOUT+ skew CLKIN-CLKOUTmatch SL5 EN5 OUT5+ IN5+ OUT5-IN5-SL6 EN6 IN6+ OUT6+ MUX OUT6-IN6-4x4 SL7 EN7 IN7+ OUT7+ IN7-OUT7-EN8 SL8 OUT8+ IN8+ OUT8-IN8-

Figure 1. Internal schematic

Figure 2. Pinout



1. Power supplies are not internally separated. All Vcc pins must be connected to the same potential.



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Maximum ratings and operating conditions 3

Absolute maximum ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied.

Table 3. Absolute maximum ratings

Symbol	Parameter	Value	Unit		
V _{CC}	Supply voltage ⁽¹⁾	4.8			
V _i	TTL inputs (operating or cold-spare)	-0.3 to +4.8	V		
V _{OUT}	LVDS outputs (operating or coldspare)	-0.3 to +4.8	V		
V _{IN}	LVDS inputs (operating or cold-spare)	-5 to +6			
V _{ID}	Differential amplitude on LVDS input (operating or cold-spare)	5	V_{PP}		
T _{stg}	Storage temperature range	-65 to +150	°C		
Tj	Maximum junction temperature	+150	C		
R _{thjc}	Thermal resistance junction to case ⁽²⁾	20	°C/W		
ESD	HBM: Human body model - All pins - LVDS inputs and outputs vs. GND	2 8	kV		
	CDM: Charge device model	500	V		

^{1.} All voltages, except the differential I/O bus voltage, are with respect to the network ground terminal.

Table 4. Operating conditions

Symbol	Parameter	Min.	Тур.	Max.	Unit
V _{CC}	Supply voltage	3	3.3	3.6	V
V _{CM}	Static common mode	- 4		+ 5	V
T _A	Ambient temperature range	-55		+125	°C

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Short-circuits can cause excessive heating. Destructive dissipation can result from short-circuits on the

4 Electrical characteristics

Total dose (MIL-STD-883 TM 1019)

The products guaranteed in radiation within the RHA QML-V system fully comply with the MIL-STD-883 TM 1019 specification.

The RHFLVDS2281 is RHA QML-V, tested and characterized in full compliance with the MIL-STD-883 specification, between 50 and 300 rad/s only (full CMOS technology).

All parameters provided in *Table 6: Electrical characteristics table* apply to both pre- and post-irradiation, as follows:

- All test are performed in accordance with MIL-PRF-38535 and test method 1019 of MIL-STD-883 for total ionizing dose (TID).
- The initial characterization is performed in qualification only on both biased and unbiased parts.
- Each wafer lot is tested at high dose rate only, in the worst bias case condition, based on the results obtained during the initial qualification.

Heavy ions

The behavior of the product when submitted to heavy ions is not tested in production. Heavy-ion trials are performed on qualification lots only.

Table 5. Radiations

Туре	Characteristics	Value	Unit
TID	High-dose rate (50 - 300 rad/sec)	300	krad
	SEL immunity up to: (with a particle angle of 60 °, at 125 °C)	135	
Heavy ions	SEL immunity up to: (with a particle angle of 0 °, at 125 °C)	67	MeV.cm ² /mg
	SET/SEU immunity up to: (at 25 °C)	22	



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In *Table 6* below, V_{CC} = 3 V to 3.6 V, capa-load (CL) = 10 pF, typical values are at T_{amb} = +25 °C, min. and max values are at T_{amb} = - 55 °C and + 125 °C unless otherwise specified.

Table 6. Electrical characteristics table

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit	
Whole ci	cuit						
I _{CCL}	Total enabled supply current, drivers and receivers enabled, not switching	V_{ID} = 400 mV and load = 100 Ω on all channels		67	80	mΛ	
I _{CCZ}	Total disabled supply current, loaded or not loaded, drivers and receivers disabled	V _{ID} = 400 mV EN and ENCK = GND			20	20 mA	
Digital in	puts EN, ENCK, and SL				•		
V _{IH}	Input voltage high		2		V _{CC}		
V _{IL}	Input voltage low		GND		0.8	V	
I _{IH}	High level input current	$V_{CC} = 3.6 \text{ V}, V_{IN} = V_{CC}$	-10		10		
I _{IL}	Low level input current	V _{CC} = 3.6 V, V _{IN} = 0	-10		10	μA	
I _{OFF}	TTL inputs power off leakage current	V _{CC} = 0 V, EN and SL = 3.6 V	-10		10	μΑ	
LVDS inp	uts						
	Differential input low threshold	+0.05 V < V _{CM} < +2.35 V			-100		
V_{TL}		-4 V < V _{CM} < +5 V			-130	m\/	
\/	/ Differential input high threshold	+0.05 V < V _{CM} < +2.35 V	+100			mV	
V_{TH}	Differential input high threshold	-4 V < V _{CM} < +5 V	+130				
V_{CL}	TTL input clamp voltage	I _{CL} = 18 mA			1.5	V	
V_{CMR}	Common mode voltage range	V _{ID} = 200 mVp-p	- 4		+5	V	
V_{CMREJ}	Common mode rejection ⁽¹⁾	F = 10 MHz			300	mVp-p	
I _{ID}	Differential input current	V _{ID} = 400 mVp-p	-10		10		
I _{ICM}	Common mode input current	V _{IC} = -4 V to +5 V	-70		70	μA	
I _{OFFIN}	LVDS input power-off leakage current ⁽²⁾	$V_{CC} = 0 \text{ V}, V_{IN} = -4 \text{ V to 5 V}$	-60		60	- MA	
C _{IN}	Input capacitance			3		pF	
LVDS out	puts						
V _{OH}	Output voltage high				1.65	V	
V_{OL}	Output voltage low		0.925			V	
V _{OD}	Differential output voltage		250		400		
DV _{OD}	Change of magnitude of V _{OD} for complementary output states				10	mV	
V _{OS}	Offset voltage		1.125		1.45	V	

Table 6. Electrical characteristics table (continued)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
DV _{OS}	Change of magnitude of V _{OS} for complementary output states				25	mV
I _{OS}	Output short-circuit current	V_{ID} = -400 mV and V_{OUT} = 0 V V_{ID} = +400 mV and V_{OUT} = 0 V	-9			mA
I _{OZ}	High impedance output current	Disabled, V _{OUT} = 3.6 V or 0V	-10		10	
I _{OFFOUT}	LVDS outputs power-off leakage current	V _{CC} = 0 V, V _{OUT} = 3.6 V	-50		+50	μA
T _S	Input to SL setup time ⁽³⁾		1.6			
T _H	Input to SL Hold time ⁽³⁾	Refer to Figure 5	1.5			
T _{Sw}	SL to Switched output ⁽³⁾				5	
t _{PHLD}	Propagation delay time, high to low	V _{ID} = 200 mVp-p, input pulse from 1.1 V to 1.3 V, V _{CM} =1.2 V	1.5		4	
t _{PLHD}	Propagation delay time, low to high	Load: refer to <i>Figure 3</i>	1.5		4	
t _{SK1}	Channel to channel skew ⁽³⁾⁽⁴⁾				0.6	
t _{SK2}	Chip to chip skew ⁽³⁾⁽⁵⁾	V _{ID} = 200 mVp-p			0.7	
t _{SKD}	Differential skew ⁽⁶⁾ (t _{PHLD} -t _{PLHD})	Load: refer to <i>Figure 6</i>			0.6	ns
t _r	Output signal rise time	Refer to <i>Figure 4</i>		0.9		
t _f	Output signal fall time	Relei to Figure 4		0.9		
t _{PLZ}	Propagation delay time, low level to high impedance output				2.8	
t _{PHZ}	Propagation delay time, high level to high impedance output	Defer to Figure 6			2.8	
t _{PZH}	Propagation delay time, high impedance to high level output	Refer to <i>Figure 6</i>			2.5	
t _{PZL}	Propagation delay time, high impedance to low level output				2.5	
Fail-safe	and cold-spare		•			
t _{D1}	Fail-safe to active time			1		ш
t _{D2}	Active to fail-safe time			1		μs

- 1. Guaranteed by characterization on bench.
- 2. All pins are floating except pin under test and $V_{\mbox{\footnotesize CC}}$.
- 3. Guaranteed by design.
- 4. t_{SK1} is the maximum delay time difference between drivers on the same device (with all inputs connected together).
- t_{SK2} is the maximum delay time difference between outputs of all devices when they operate with the same supply voltage, at the same temperature.
- 6. t_{SKD} is the maximum delay time difference between t_{PHLD} and t_{PLHD} (see Figure 4).



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Electrical characteristics RHFLVDS2281

Cold sparing

The RHFLVDS2281 features a cold spare input and output buffer. In high reliability applications, cold sparing enables a redundant device to be tied to the data bus with its power supply at 0 V (V_{CC} = GND) without affecting the bus signals or injecting current from the I/Os to the power supplies. Cold sparing also allows redundant devices to be kept powered off so that they can be switched on only when required. This has no impact on the application. Cold sparing is achieved by implementing a high impedance between the I/Os and V_{CC} . ESD protection is ensured through a non-conventional dedicated structure.

Fail-safe

In many applications, inputs need a fail-safe function to avoid an uncertain output state when the inputs are not connected properly. In case of an LVDS input short circuit or floating inputs, the LVDS outputs remain in stable logic-high state.



RHFLVDS2281 Test circuit

5 Test circuit

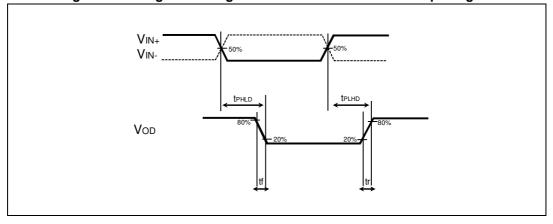
VIN+

 $V_{CM}=(V_{IN+}+V_{IN-})/2$

VID Receiver No. CL=10pF CL=10pF

Figure 3. Voltage and current definition





- 1. All input pulses are supplied by a generator with the following characteristics: t_r or $t_f \le 1$ ns, f=1 MHz, $Z_O=50$ Ω , and duty cycle = 50%.
- 2. The product is guaranteed with C_L = 10 pF.

Test circuit RHFLVDS2281

Figure 5. MUX switch timings

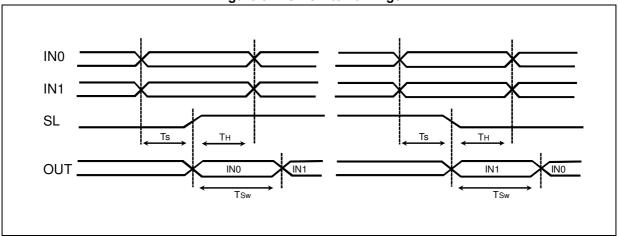
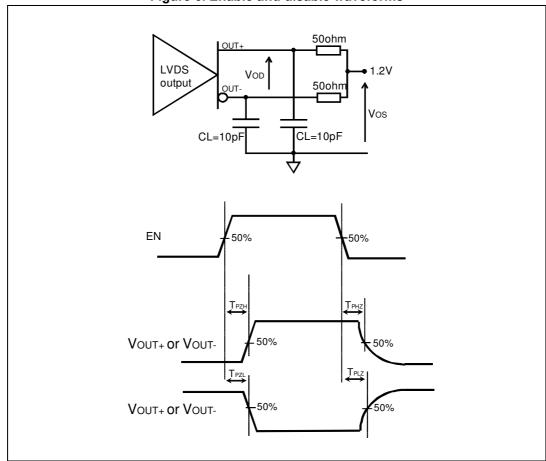


Figure 6. Enable and disable waveforms



1. All input pulses are supplied by a generator with the following characteristics on EN: t_r or $t_f \le 1$ ns, F = 500 kHz, pulse width = 500 ns.

RHFLVDS2281 Package information

6 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: www.st.com. ECOPACK is an ST trademark.



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Package information RHFLVDS2281

6.1 Ceramic Flat-64 package information

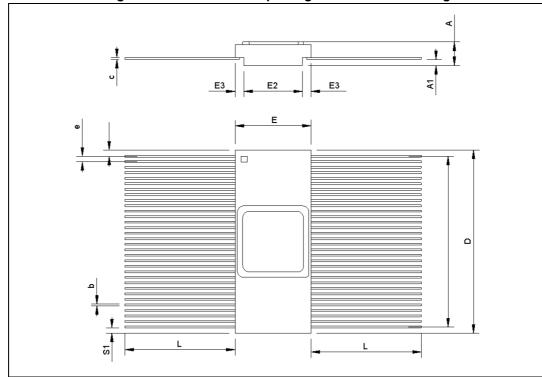


Figure 7. Ceramic Flat 64 package mechanical drawing

1. The upper metallic lid is electrically connected to ground.

Table 7. Ceramic Flat 64 package mechanical data

	Dimensions							
Ref.	Millimeters		imeters In					
	Min.	Тур.	Max.	Min.	Тур.	Max.		
Α	2.41	2.66	2.92	0.095	0.105	0.115		
A1	0.33	-	-	0.013	-	-		
b	0.18	0.2	0.23	0.007	0.008	0.009		
С	0.15	0.2	0.25	0.006	0.008	0.010		
D	20.91	21.11	21.31	0.823	0.831	0.839		
E	8.64	8.76	8.89	0.340	0.345	0.350		
E2	6.57	6.72	6.87	0.259	0.265	0.270		
E3	-	1.02	-	-	0.040	-		
е	-	0.635	-	-	0.025	-		
L	12.45	12.7	12.95	0.49	0.5	0.51		
S1	-	0.61	-	-	0.024	-		

7 Ordering information

Table 8. Order codes

Order code	SMD ⁽¹⁾	Quality level	Package	Lead- finish	Marking ⁽²⁾	Packing
RHFLVDS2281K1	-	Engineering model	Flat-64 with	Gold	RHFLVDS2281K1	Conductive Strip pack
RHFLVDS2281K01V	5962F14234	QML-V Flight	grounded lid	Gold	5962F1423401VXC	Only pack

^{1.} Standard microcircuit drawing.

Note: Contact your ST sales office for information about the specific conditions for products in die form.



^{2.} Specific marking only. Complete marking includes the following:

ST logo

⁻ Date code (date the package was sealed) in YYWWA (year, week, and lot index of week)

⁻ Country of origin (FR = France)

8 Shipping information

Date code

The date code (date the package was sealed) is structured as follows:

- Engineering model: 3yywwz
- · Flight model: yywwz

Where:

yy = last two digits of the year, ww = week digits, z = lot index of the week

Product documentation

Each product shipment includes a set of associated documentation within the shipment box. This documentation depends on the quality level of the products, as detailed in *Table 9* below.

The Certificate of Conformance is provided on paper whatever the quality level. For QML parts, complete documentation, including the Certificate of Conformance, is provided on a CDROM.

Note: Contact ST for details on the documentation of other quality levels.



Table 9. Product documentation

Quality level	Item
Engineering Model	Certificate of Conformance including: - Customer name - Customer Purchase Order number - ST Sales Order number & Item - ST Part Number - Quantity delivered - Date Code - Reference to ST datasheet - Reference to TN1181 on Engineering Models - ST Rennes assembly lot ID
QML-V Flight	Certificate of Conformance including: - Customer name - Customer Purchase Order number - ST Sales Order number & Item - ST Part Number - Quantity delivered - Date Code - Serial numbers - Group C reference - Group D reference - Reference to the applicable SMD - ST Rennes assembly lot ID
	Quality Control Inspection (groups A, B, C, D, E) Screening electrical data in/out summary
	Precap report
	PIND test (Particle Impact Noise Detection)
	SEM inspection report (Scanning Electronic Microscope)
	X-Ray plates



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Revision history RHFLVDS2281

9 Revision history

Table 10. Document revision history

Date	Revision	Changes
04-Mar-2015	1	Initial release.
10-Nov-2023	2	Added V_{IN} and V_{ID} in Table 4: Absolute maximum ratings.
13-May-2025	3	Updated features on the cover page, V_{ID} value in <i>Table 3</i> , V_{TL} and V_{TH} value in <i>Table 6</i> , <i>Section 8</i> .

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